

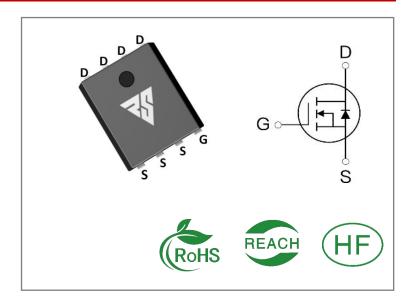
ID	R _{DS} (ON)(Typ)	VDSS
150A	3.5 m Ω	100V

Applications:

- Load Switch
- PWM Applications
- Power Managment

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS100N150HG	DFN5*6	RS100N150HG	Tape&reel	5000 PCS

Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RS100N150HG	Units
VDSS	Drain-to-Source Voltage	100	V
ID	Continuous Drain Current TC=25℃	150	
ID	Continuous Drain Current TC=100℃	94.5	Α
IDM	Pulsed Drain Current (Note*1)	600	
PD	Power Dissipation	167	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH, VDD = 50V, RG = 25 Ω ,TC=25 $^{\circ}$ C	120	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	$^{\circ}\!\mathrm{C}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS100N150HG	Units	Test Conditions
RθJC	Junction-to-Case	0.75	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 150°
RθJA	Junction-to- Ambient	50		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	100			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=80V,VGS=0 V
ICCC	Gate- to- Source Forward Leakage			100		VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
,	Static Drain- to- Source On-		3.5	4.2	mΩ	VGS=10V,ID=20A
RDS(on)	Resistance(Note*2)		4.5	5.5	mΩ	VGS=4.5V,ID=20 A
VGS(TH)	Gate Threshold Voltage	2	3	4	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		14.3		nS	VDS=50V ID=50A RG=3Ω VGS=10V
trise	Rise Time		20.8			
td(OFF)	Turn- OFF Delay Time		57.7			
tfall	Fall Time		31.9			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		3470			VGS=0V
Coss	Output Capacitance		1560		pF	VDS=50V
Crss	Reverse Transfer Capacitance		79			f=1MHz
Qg	Total Gate Charge		74.5			VDS=50V
Qgs	Gate- to- Source Charge		14.2		nC	ID=50A
Qgd	Gate-to-Drain(" Miller") Charge		22.5			VGS=10V

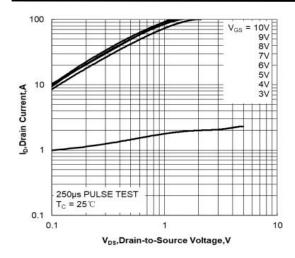
Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			150	Α	Integral pn- diode
ISM	Maximum Pulsed Current			600	Α	in MOSFET
VSD	Diode Forward Voltage			1.2	V	IS=20A,VGS=0V
trr	Reverse Recovery Time		115		nS	VGS=0V
Qrr	Reverse Recovery Charge		520		μC	IS=20A di/dt=100A/μs

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width ≤ 300µs, Duty Cycle ≤ 1%

Typical Feature Curve





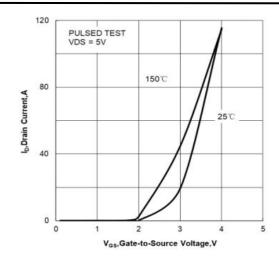


Figure 2. Transfer Characteristics



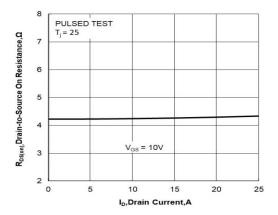


Figure 3. Drain-to-Source On Resistance vs Drain Current

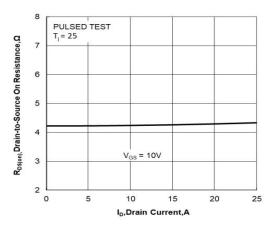


Figure 3. Drain-to-Source On Resistance vs Drain Current

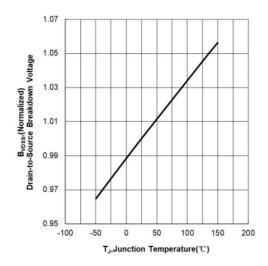


Figure 7. Normalized Breakdown Voltage vs Junction Temperature

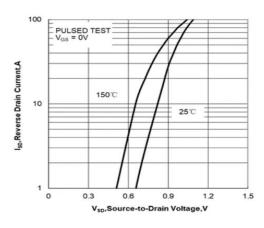


Figure 4. Body Diode Forward Voltage vs Source Current and Temperature

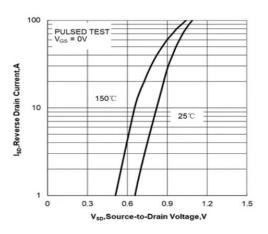


Figure 4. Body Diode Forward Voltage vs Source Current and Temperature

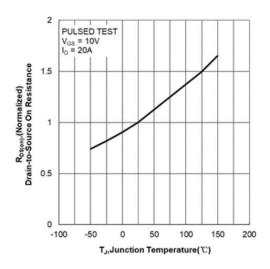


Figure 8. Normalized On Resistance vs

Junction Temperature



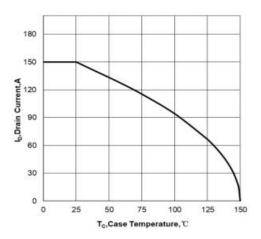


Figure 9. Maximum Continuous Drain Current vs Case Temperature

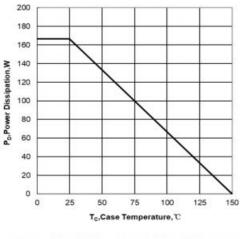


Figure 10. Maximum Power Dissipation vs Case Temperature

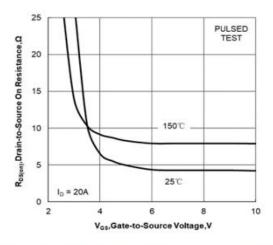


Figure 11. Drain-to-Source On Resistance vs Gate
Voltage and Drain Current

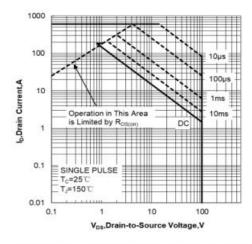


Figure 12. Maximum Safe Operating Area

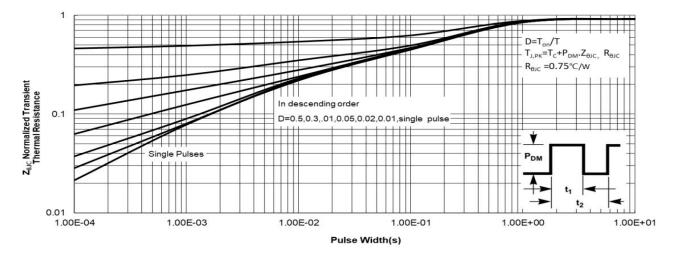


Figure 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Test ircuits and Waveforms

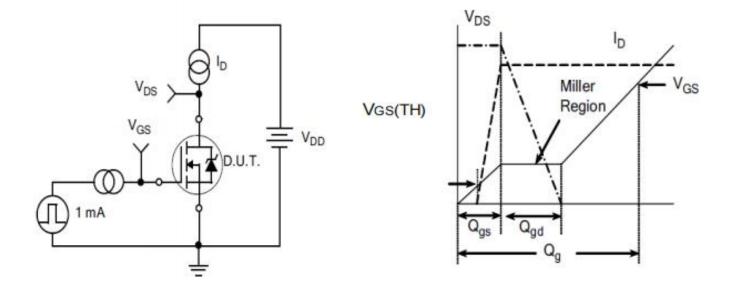


Figure A.
Gate Charge Test Circuit

Figure B. Gate Charge Waveform

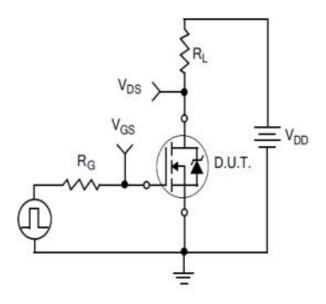


Figure C.
Resistive Switching Test Circuit

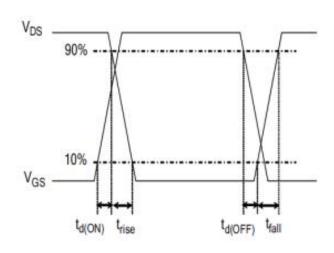


Figure D.
Resistive Switching Waveforms



Test Circuits and Waveforms

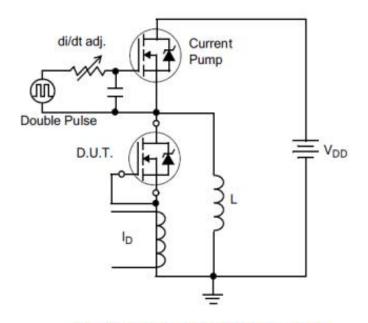


Figure E.Diode Reverse Recovery Test Circuit

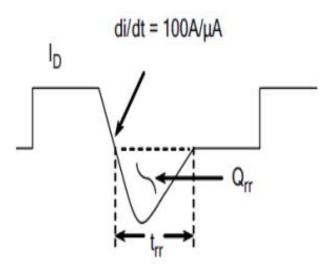


Figure F.Diode Reverse Recovery Waveform

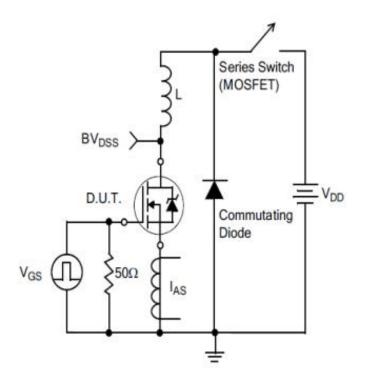


Figure G.Unclamped Inductive Switching Test Circuit

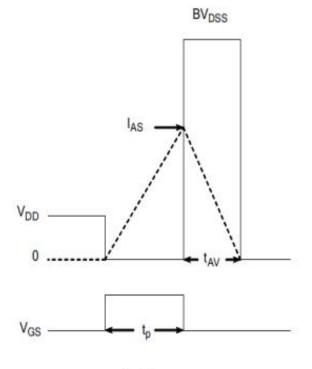
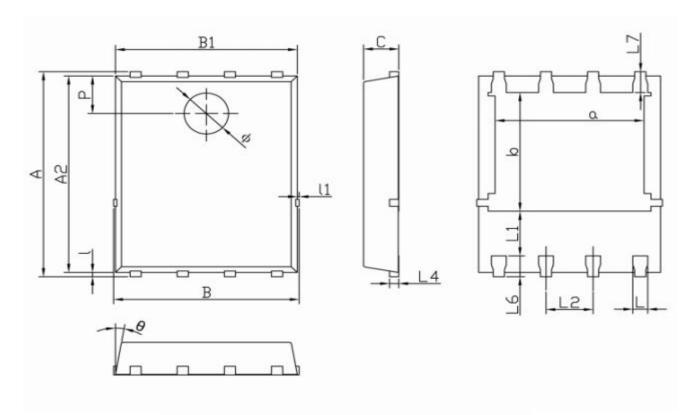


Figure H.Unclamped Inductive Switching Waveforms



Package outline drawing(DFN5*6 Unit: mm)



D	Dimensions In Millimeterer						
Symbol	MIN	TYP	MAX				
Α	5.90	6.00	6.10				
a	3.91	4.01	4.11				
A2	5.70	5.75	5.80				
В	4.90	5.00	5.10				
b	3.37	3.47	3.57				
B1	4.80	4.90	5.00				
С	0.90	0.95	1.00				
L	0.35	0.40	0.45				
ι	0.06	0.13	0.20				
∟1	1.10		2-0				
l1	-	_	0.10				
L2	1.17	1.27	1.37				
L4	0.21	0.26	0.34				
L6	0.51	0.61	0.71				
L7	0.51	0.61	0.71				
Р	1.00	1.10	1.20				
θ	8*	10°	12°				
ф	1.10	1.20	1.30				



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